

Attorney Docket No. 04083/LH

This paper is being submitted via
EFS-Web on April 28, 2008

**IN THE UNITED STATES PATENT
AND TRADEMARK OFFICE**

Applicant(s) : Takashi YONEYAMA, et al.

Serial No. : 10/773,524

Confirm. No.: 7190

Filed : February 6, 2004

In the event that this Paper is late filed, and the necessary petition for extension of time is not filed concurrently herewith, please consider this as a Petition for the requisite extension of time, and to the extent not already paid, authorization to charge the extension fee to Account No. 06-1378. In addition, authorization is hereby given to charge any fees for which payment has not been submitted, or to credit any overpayments, to Account No. 06-1378.

For : DEFECT INSPECTION APPARATUS AND
DEFECT INSPECTION METHOD

Art Unit : 2624

Examiner : Tsung Yin Tsai

PETITION FOR EXTENSION OF TIME

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

S I R:

Applicants hereby petition for a two (2) month extension of time for timely filing of the papers filed concurrently herewith.

Extended time expires April 26, 2008 (Saturday), which is automatically extended to Monday, April 28, 2008.

The Patent Office fee of \$460.00 is being paid by credit card herewith. If any further fees are required, authorization is given to charge same against Account No. 06-1378.

Respectfully submitted,

/Douglas Holtz/

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